

**Search Notes****Application/Control No.**

10/589,997

**Examiner**

Son T. Nguyen

**Applicant(s)/Patent under  
Reexamination**

HOYOS ET AL.

**Art Unit**

3643

**SEARCHED**

Class	Subclass	Date	Examiner
54	8,9	9/15/2008	STN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
54	9	9/15/2008	stn

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
IPC foreign search, see printouts	9/15/2008	stn
interference claim text search, see printouts	9/15/2008	STN